

# Semiconductor Device Physics

## Lecture 9

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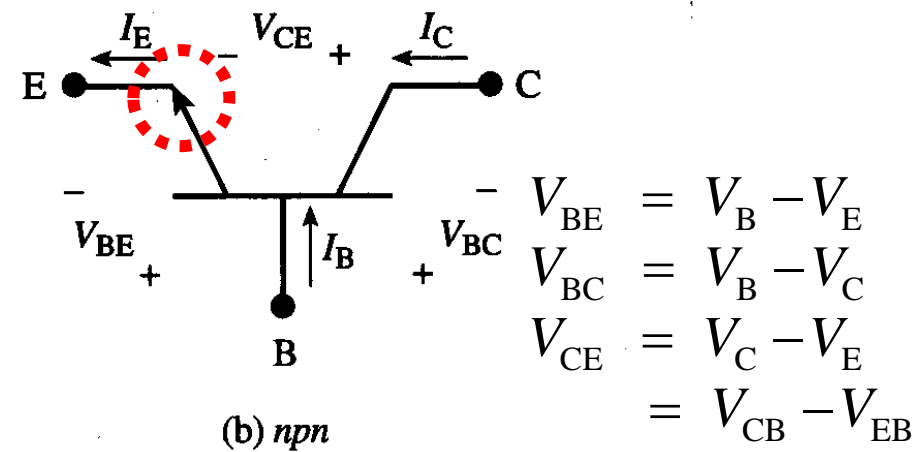
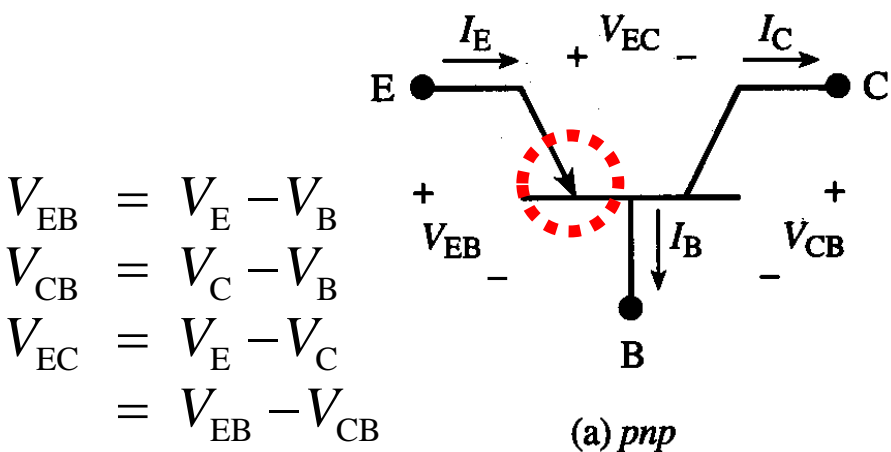
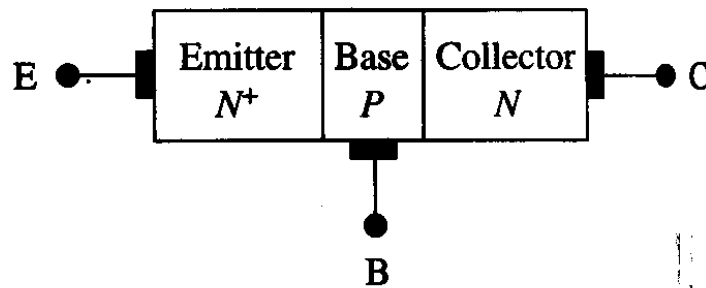
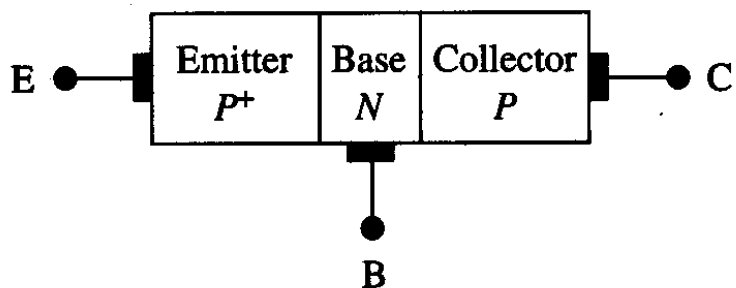
# Chapter 10

## BJT Fundamentals

# Bipolar Junction Transistors (BJTs)

- Over the past decades, the higher layout density and low-power advantage of CMOS (**C**omplementary **M**etal–**O**xide–**S**emiconductor) has eroded away the BJT's dominance in integrated-circuit products.
    - Higher circuit density → better system performance
  - BJTs are still preferred in **some** digital-circuit and analog-circuit applications because of their high speed and superior gain
    - Faster circuit speed (+)
    - Larger power dissipation (–)
- Transistor: current flowing between two terminals is controlled by a third terminal

- There are two types of BJT: *pnp* and *npn*.

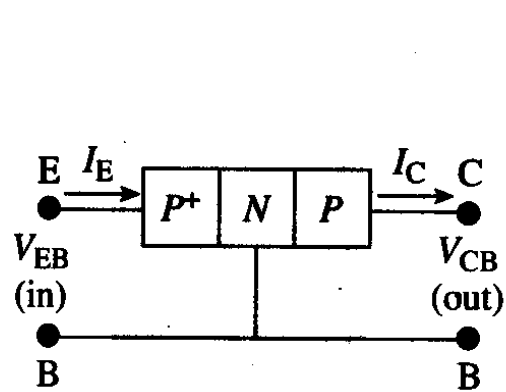


$$\begin{aligned}
 V_{EB} &= V_E - V_B \\
 V_{CB} &= V_C - V_B \\
 V_{EC} &= V_E - V_C \\
 &= V_{EB} - V_{CB}
 \end{aligned}$$

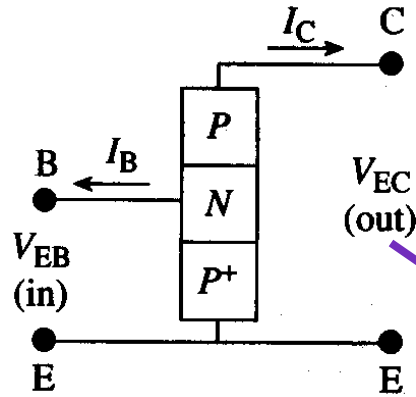
$$\begin{aligned}
 V_{BE} &= V_B - V_E \\
 V_{BC} &= V_B - V_C \\
 V_{CE} &= V_C - V_E \\
 &= V_{CB} - V_{EB}
 \end{aligned}$$

- The convention used in the textbook does not follow IEEE convention, where currents flowing into a terminal is defined as positive.
- We will follow the normal convention: . . . . .

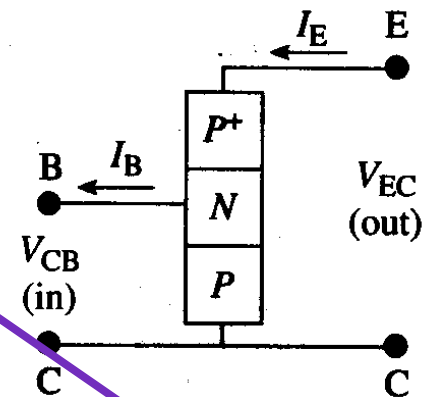
# Circuit Configurations



(a) Common base



(b) Common emitter

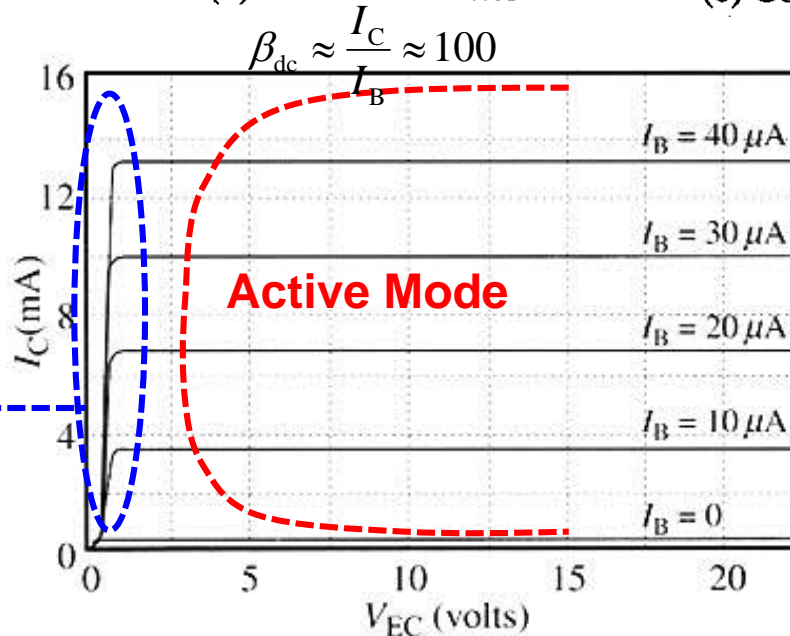


(c) Common collector

## Common-Emitter I-V Characteristics

Saturation Mode

$$I_C < \beta I_B$$

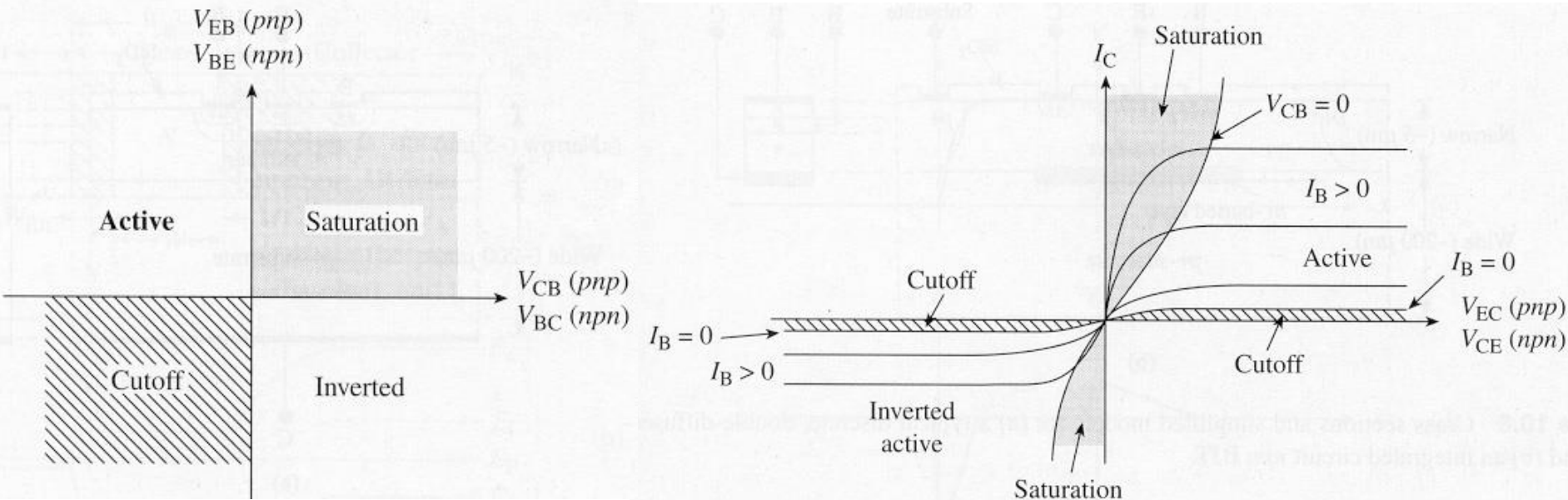


Most popular configuration

In active mode,  $\beta_{dc}$  is the common emitter dc current gain

# Modes of Operation

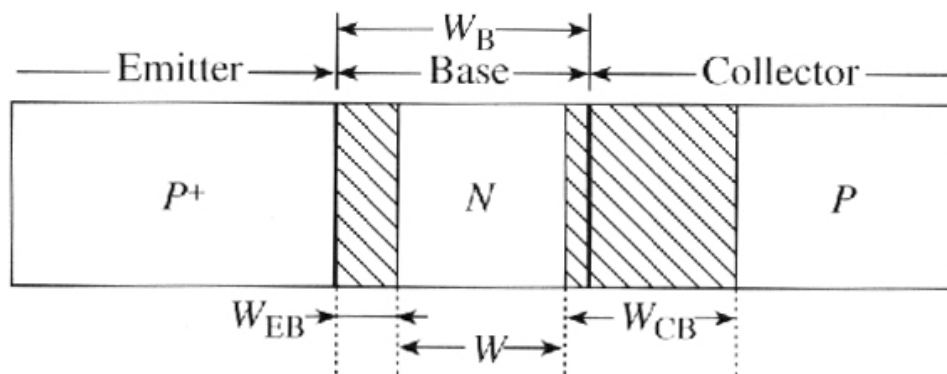
## Common-Emitter Output Characteristics



Mode	E-B Junction	C-B Junction
Saturation	forward bias	forward bias
Active/Forward	forward bias	reverse bias
Inverted	reverse bias	forward bias
Cutoff	reverse bias	reverse bias

## BJT Electrostatics

- Under equilibrium and normal operating conditions, the BJT may be viewed electrostatically as two independent  $pn$  junctions.

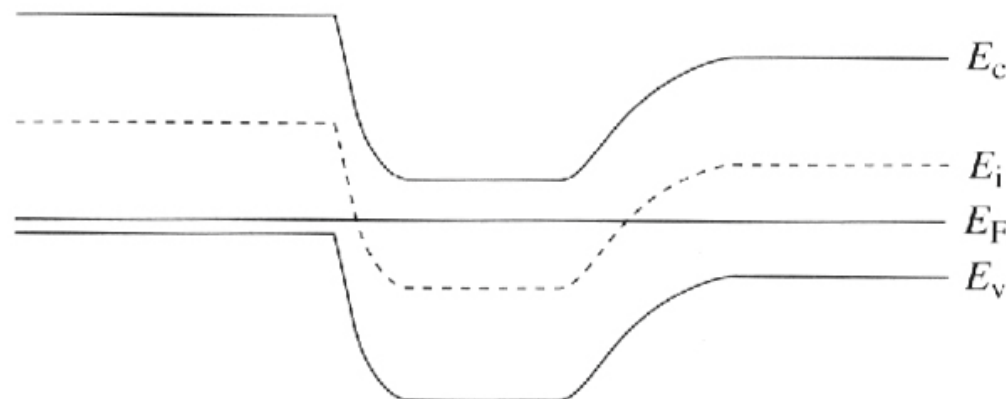


$$N_{AE} \gg N_{DB} > N_{AC}$$

$$W_{CB} > W_{EB}$$

$$W = W_B - x_{nEB} - x_{nCB}$$

**W: quasineutral base width**

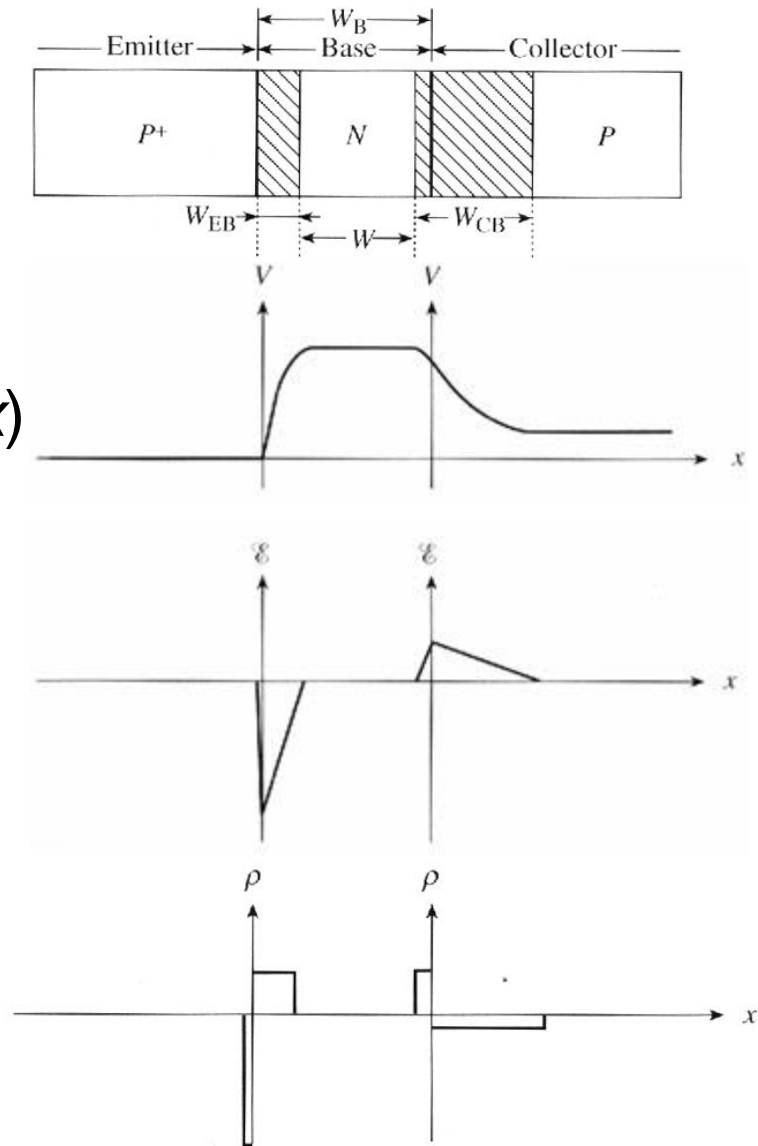


## BJT Electrostatics

■ Electrostatic potential,  $V(x)$

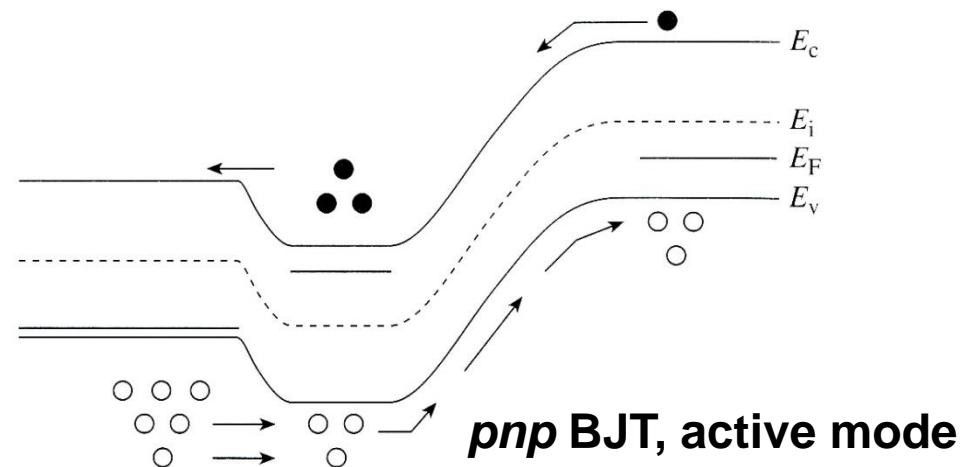
■ Electric field,  $\mathcal{E}(x)$

■ Charge density,  $\rho(x)$



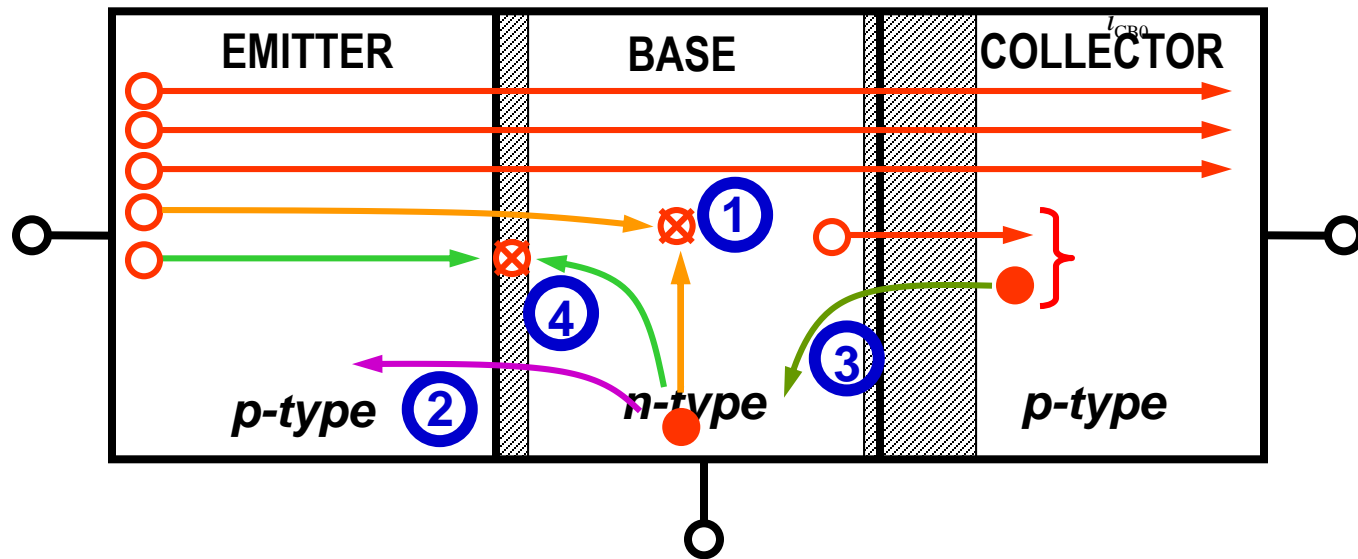


- Important features of a good transistor:
  - Injected minority carriers do not recombine in the neutral base region → **short base,  $W \ll L_p$  for *pnp* transistor**
  - Emitter current is comprised almost entirely of carriers injected into the base rather than carriers injected into the emitter → **the emitter must be doped heavier than the base**

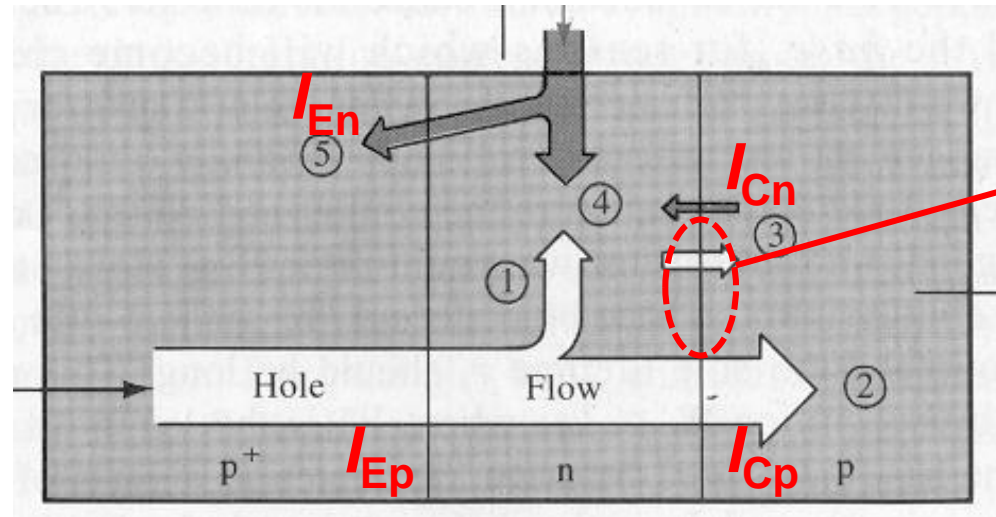


# Base Current (Active Bias)

- The base current consists of majority carriers (electrons) supplied for:
  1. Recombination of injected minority carriers in the base
  2. Injection of carriers into the emitter
  3. Reverse saturation current in collector junction
  4. Recombination in the base-emitter depletion region



# BJT Performance Parameters (*pnp*)



Negligible compared to holes injected from emitter

## Emitter Efficiency

$$\gamma = \frac{I_{Ep}}{I_E} = \frac{I_{Ep}}{I_{Ep} + I_{En}}$$

- Decrease ⑤ relative to ① and ② to increase efficiency

## Base Transport Factor

$$\alpha_T = \frac{I_{Cp}}{I_{Ep}}$$

- Decrease ① relative to ② to increase transport factor

Common base dc current gain:  $\alpha_{dc} = \gamma\alpha_T$

# Collector Current (Active Bias)

- The collector current is composed of:
  - Holes injected from emitter, which do not recombine in the base ②
  - Reverse saturation current of collector junction ③

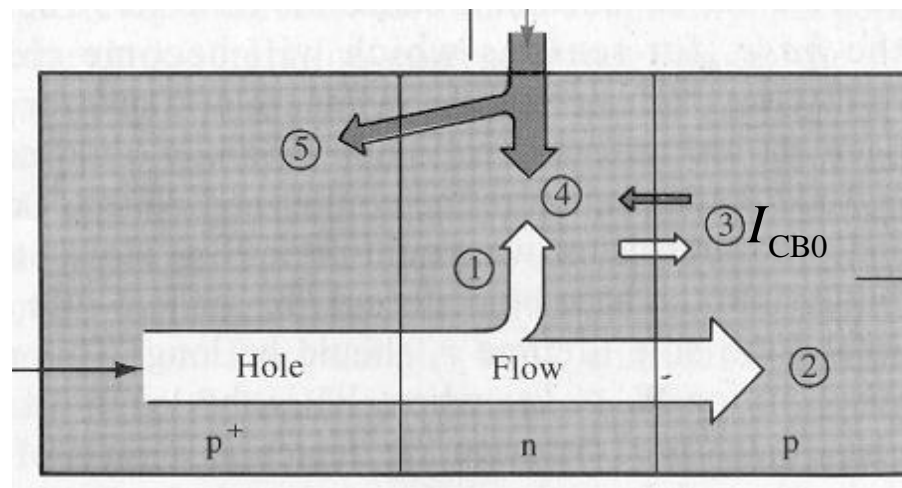
$$I_C = \alpha_{dc} I_E + I_{CB0}$$

$I_{CB0}$  : collector current when  $I_E = 0$

$$I_C = \alpha_{dc} (I_C + I_B) + I_{CB0}$$

$$I_C = \frac{\alpha_{dc}}{1 - \alpha_{dc}} I_B + \frac{I_{CB0}}{1 - \alpha_{dc}}$$

$$I_C = \beta_{dc} I_B + I_{CE0}$$

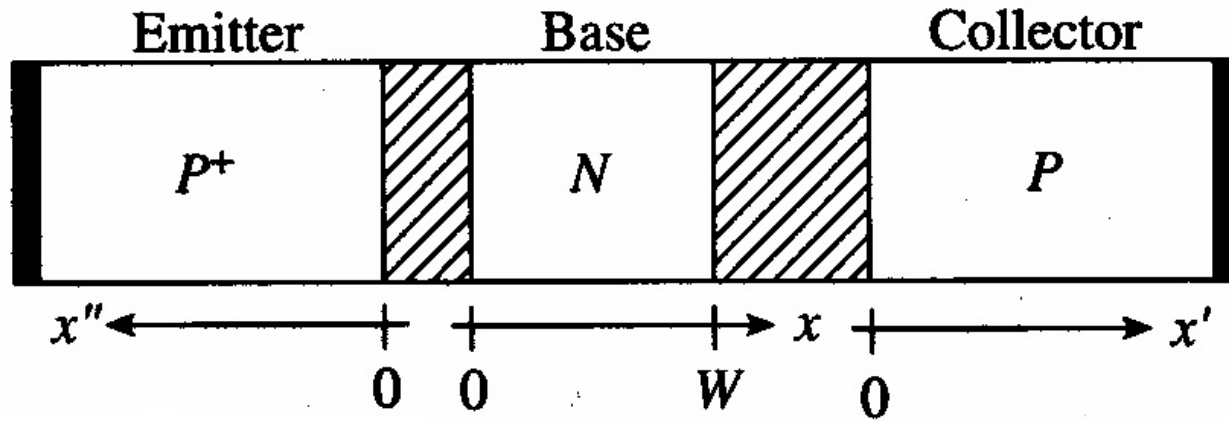


Common emitter dc current gain:

$$\beta_{dc} = \frac{\alpha_{dc}}{1 - \alpha_{dc}} \approx \frac{I_C}{I_B}$$

# Chapter 11

## BJT Static Characteristics

Notation (*pnp* BJT)

Minority  
carrier  
constants

$$N_E = N_{AE}$$

$$N_B = N_{DB}$$

$$N_C = N_{AC}$$

$$D_E = D_N$$

$$D_B = D_P$$

$$D_C = D_N$$

$$\tau_E = \tau_n$$

$$\tau_B = \tau_p$$

$$\tau_C = \tau_n$$

$$L_E = L_N$$

$$L_B = L_P$$

$$L_C = L_N$$

$$n_{E0} = n_{p0}$$

$$p_{B0} = p_{n0}$$

$$n_{C0} = n_{p0}$$

$$= n_i^2 / N_E$$

$$= n_i^2 / N_B$$

$$= n_i^2 / N_C$$

# Emitter Region

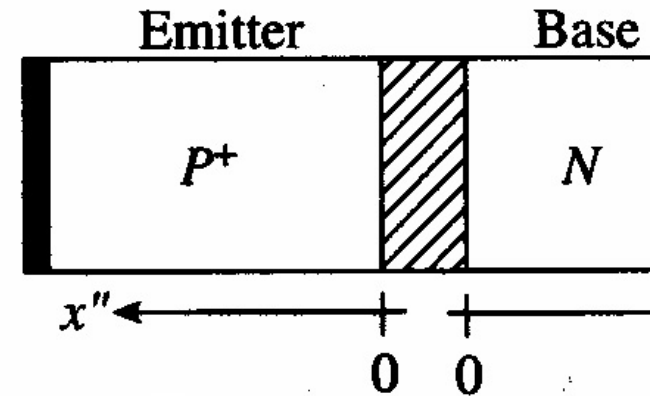
- Diffusion equation:

$$0 = D_E \frac{d^2 \Delta n_E}{dx''^2} - \frac{\Delta n_E}{\tau_E}$$

- Boundary conditions:

$$\Delta n_E(x'' \rightarrow \infty) = 0$$

$$\Delta n_E(x'' = 0) = n_{E0} (e^{qV_{EB}/kT} - 1)$$



## Base Region

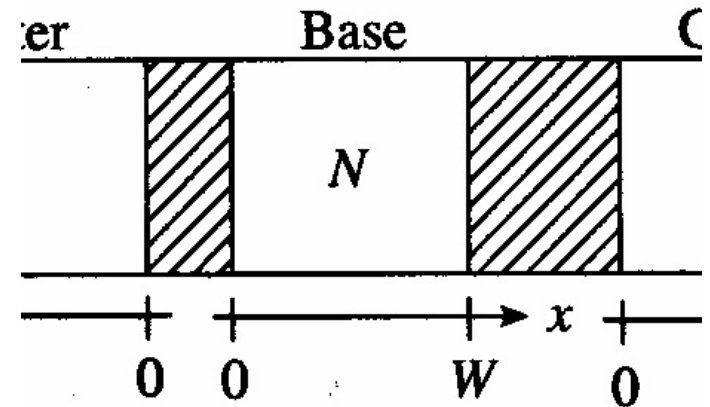
- Diffusion equation:

$$0 = D_B \frac{d^2 \Delta p_B}{dx^2} - \frac{\Delta p_B}{\tau_B}$$

- Boundary conditions:

$$\Delta p_B(0) = p_{B0} (e^{qV_{EB}/kT} - 1)$$

$$\Delta p_B(W) = p_{B0} (e^{qV_{CB}/kT} - 1)$$





# Collector Region

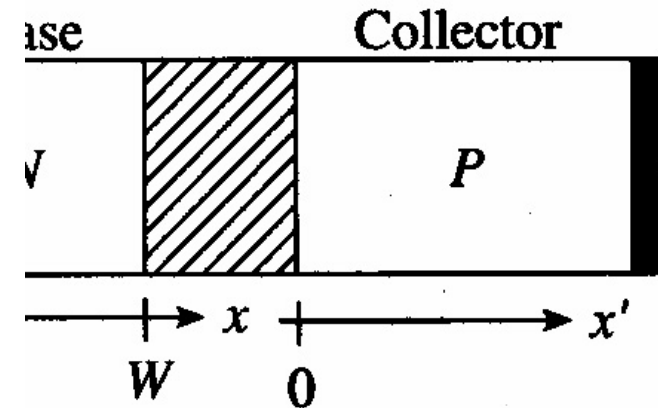
- Diffusion equation:

$$0 = D_C \frac{d^2 \Delta n_C}{dx'^2} - \frac{\Delta n_C}{\tau_C}$$

- Boundary conditions:

$$\Delta n_C(x' \rightarrow \infty) = 0$$

$$\Delta n_C(x' = 0) = n_{C0} (e^{qV_{CB}/kT} - 1)$$



# Ideal Transistor Analysis

- Solve the minority-carrier diffusion equation in each quasi-neutral region to obtain excess minority-carrier profiles

- Each region has different set of boundary conditions

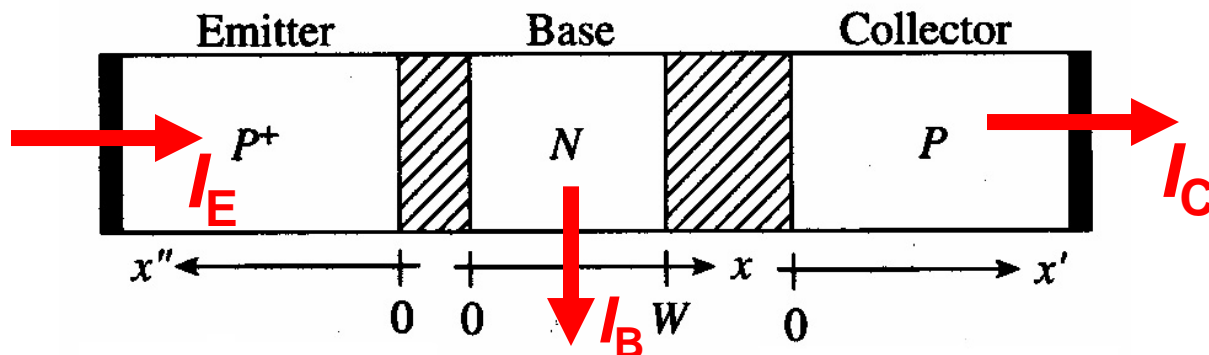
- Evaluate minority-carrier diffusion currents at edges of depletion regions

$$\begin{aligned} & \square n_E(x''), \\ & \square p_B(x), \\ & \square n_C(x') \end{aligned}$$

$$I_{En} = -qAD_E \left. \frac{d\Delta n_E}{dx''} \right|_{x''=0} \quad I_{Ep} = -qAD_B \left. \frac{d\Delta p_B}{dx} \right|_{x=0}$$

$$I_{Cn} = qAD_C \left. \frac{d\Delta n_C}{dx'} \right|_{x'=0} \quad I_{Cp} = -qAD_B \left. \frac{d\Delta p_B}{dx} \right|_{x=W}$$

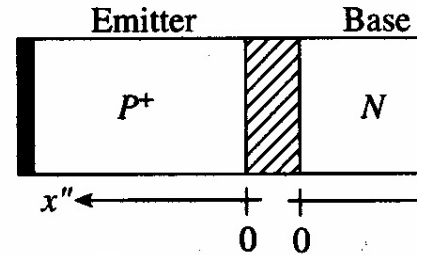
- Add hole and electron components together  $\rightarrow$  terminal currents is obtained



$$\begin{aligned} I_E &= I_{Ep} + I_{En} \\ I_C &= I_{Cp} + I_{Cn} \\ I_B &= I_E - I_C \end{aligned}$$

# Emitter Region Solution

- Diffusion equation: 
$$0 = D_E \frac{d^2 \Delta n_E}{dx''^2} - \frac{\Delta n_E}{\tau_E}$$
- General solution: 
$$\Delta n_E(x'') = A_1 e^{-x''/L_E} + A_2 e^{x''/L_E}$$



- Boundary conditions: 
$$\Delta n_E(x'' \rightarrow \infty) = 0$$
  

$$\Delta n_E(x'' = 0) = n_{E0} (e^{qV_{EB}/kT} - 1)$$

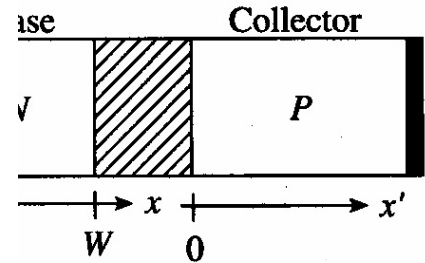
- Solution 
$$\Delta n_E(x'') = n_{E0} (e^{qV_{EB}/kT} - 1) e^{-x''/L_E}$$

$$I_{En} = -qAD_E \left. \frac{d\Delta n_E}{dx''} \right|_{x''=0} = qA \frac{D_E}{L_E} n_{E0} (e^{qV_{EB}/kT} - 1)$$

# Collector Region Solution

- Diffusion equation: 
$$0 = D_C \frac{d^2 \Delta n_C}{dx'^2} - \frac{\Delta n_C}{\tau_C}$$
- General solution: 
$$\Delta n_C(x') = A_1 e^{-x'/L_C} + A_2 e^{x'/L_C}$$
- Boundary conditions: 
$$\Delta n_C(x' \rightarrow \infty) = 0$$
  

$$\Delta n_C(x' = 0) = n_{C0} (e^{qV_{CB}/kT} - 1)$$
- Solution 
$$\Delta n_C(x') = n_{C0} (e^{qV_{CB}/kT} - 1) e^{-x'/L_C}$$

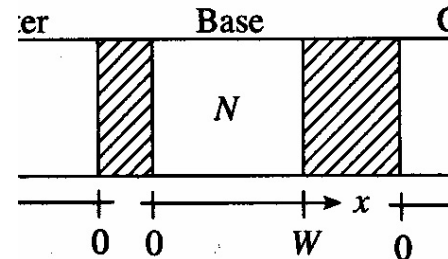


$$I_{Cn} = qAD_C \left. \frac{d\Delta n_C}{dx'} \right|_{x'=0} = -qA \frac{D_C}{L_C} n_{C0} (e^{qV_{CB}/kT} - 1)$$

# Base Region Solution

- Diffusion equation: 
$$0 = D_B \frac{d^2 \Delta n_B}{dx^2} - \frac{\Delta p_B}{\tau_B}$$
- General solution: 
$$\Delta p_B(x) = A_1 e^{-x/L_B} + A_2 e^{x/L_B}$$
- Boundary conditions: 
$$\Delta p_B(0) = p_{B0} (e^{qV_{EB}/kT} - 1)$$
  

$$\Delta p_B(W) = p_{B0} (e^{qV_{CB}/kT} - 1)$$



- Solution

$$\Delta p_B(x) = p_{B0} (e^{qV_{EB}/kT} - 1) \left( \frac{e^{(W-x)/L_B} - e^{-(W-x)/L_B}}{e^{W/L_B} - e^{-W/L_B}} \right) + p_{B0} (e^{qV_{CB}/kT} - 1) \left( \frac{e^{x/L_B} - e^{-x/L_B}}{e^{W/L_B} - e^{-W/L_B}} \right)$$

## Base Region Solution

■ Since  $\sinh(\xi) = \frac{e^{\xi} - e^{-\xi}}{2}$

■ We can write 
$$\Delta p_B(x) = p_{B0} (e^{qV_{EB}/kT} - 1) \left( \frac{e^{(W-x)/L_B} - e^{-(W-x)/L_B}}{e^{W/L_B} - e^{-W/L_B}} \right) + p_{B0} (e^{qV_{CB}/kT} - 1) \left( \frac{e^{x/L_B} - e^{-x/L_B}}{e^{W/L_B} - e^{-W/L_B}} \right)$$

as 
$$\Delta p_B(x) = p_{B0} (e^{qV_{EB}/kT} - 1) \frac{\sinh[(W-x)/L_B]}{\sinh(W/L_B)} + p_{B0} (e^{qV_{CB}/kT} - 1) \frac{\sinh(x/L_B)}{\sinh(W/L_B)}$$

## Base Region Solution

■ Since  $\frac{d}{d\xi} \sinh(\xi) = \frac{d}{d\xi} \left( \frac{e^\xi - e^{-\xi}}{2} \right) = \frac{e^\xi + e^{-\xi}}{2} = \cosh(\xi)$

$$I_{Ep} = -qAD_B \left. \frac{d\Delta p_B}{dx} \right|_{x=0}$$

$$= qA \frac{D_B}{L_B} p_{B0} \left[ \frac{\cosh(W/L_B)}{\sinh(W/L_B)} (e^{qV_{EB}/kT} - 1) - \frac{1}{\sinh(W/L_B)} (e^{qV_{CB}/kT} - 1) \right]$$

$$I_{Cp} = -qAD_B \left. \frac{d\Delta p_B}{dx} \right|_{x=W}$$

$$= qA \frac{D_B}{L_B} p_{B0} \left[ \frac{1}{\sinh(W/L_B)} (e^{qV_{EB}/kT} - 1) - \frac{\cosh(W/L_B)}{\sinh(W/L_B)} (e^{qV_{CB}/kT} - 1) \right]$$

## Terminal Currents

■ Since  $I_E = I_{En} + I_{Ep}$ ,  $I_C = I_{Cn} + I_{Cp}$

■ Then  $\Rightarrow I_E = qA \left[ \left( \frac{D_E}{L_E} n_{E0} + \frac{D_B}{L_B} p_{B0} \frac{\cosh(W/L_B)}{\sinh(W/L_B)} \right) (e^{qV_{EB}/kT} - 1) \right. \\ \left. - \left( \frac{D_B}{L_B} p_{B0} \frac{1}{\sinh(W/L_B)} \right) (e^{qV_{CB}/kT} - 1) \right]$

$$\Rightarrow I_C = qA \left[ \left( \frac{D_B}{L_B} p_{B0} \frac{1}{\sinh(W/L_B)} \right) (e^{qV_{EB}/kT} - 1) \right. \\ \left. - \left( \frac{D_C}{L_C} n_{C0} + \frac{D_B}{L_B} p_{B0} \frac{\cosh(W/L_B)}{\sinh(W/L_B)} \right) (e^{qV_{CB}/kT} - 1) \right]$$

$$\Rightarrow I_B = I_E - I_C$$



# Simplified Relationships

- To achieve high current gain, a typical BJT will be constructed so that  $W \ll L_B$ .

- Using the limit value  $\lim_{\xi \rightarrow 0} \sinh(\xi) = \xi$

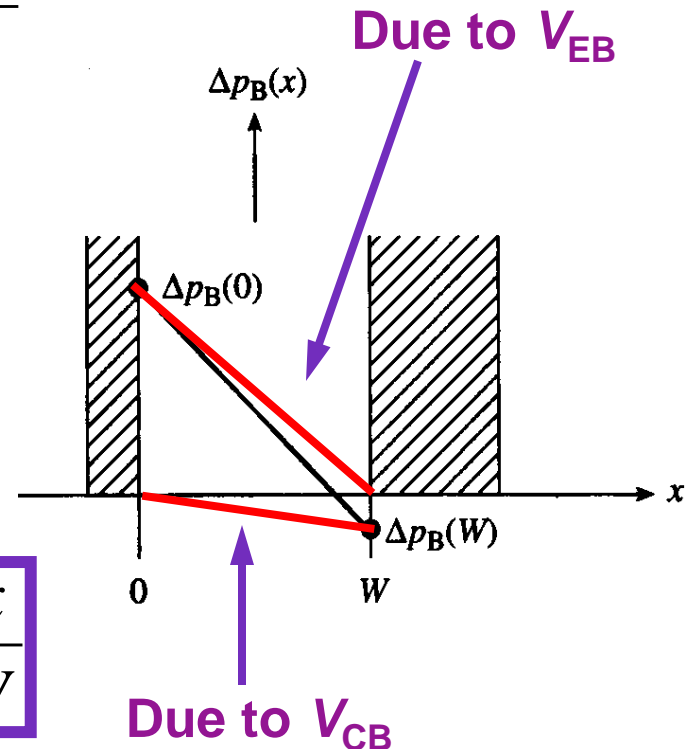
$$\lim_{\xi \rightarrow 0} \cosh(\xi) = 1 + \frac{\xi^2}{2}$$

- We will have

$$\Delta p_B(x) \approx p_{B0} (e^{qV_{EB}/kT} - 1) \left(1 - \frac{x}{W}\right) + p_{B0} (e^{qV_{CB}/kT} - 1) \left(\frac{x}{W}\right)$$

$\Delta p_B(0)$  ← (points to the first term)       $\Delta p_B(W)$  ← (points to the second term)

$$\Delta p_B(x) = \Delta p_B(0) + [\Delta p_B(W) - \Delta p_B(0)] \frac{x}{W}$$



# Performance Parameters

- For specific condition of
  - “Active Mode”: emitter junction is forward biased and collector junction is reverse biased
  - $W \ll L_B$ ,  $n_{E0}/p_{B0} = N_B/N_E$

$$\gamma = \frac{1}{1 + \frac{D_E}{D_B} \frac{N_B}{N_E} \frac{W}{L_E}}$$

$$\alpha_T = \frac{1}{1 + \frac{1}{2} \left( \frac{W}{L_B} \right)^2}$$

$$\alpha_{dc} = \frac{1}{1 + \frac{D_E}{D_B} \frac{N_B}{N_E} \frac{W}{L_E} + \frac{1}{2} \left( \frac{W}{L_B} \right)^2}, \quad \beta_{dc} = \frac{1}{\frac{D_E}{D_B} \frac{N_B}{N_E} \frac{W}{L_E} + \frac{1}{2} \left( \frac{W}{L_B} \right)^2}$$

# Ebers-Moll BJT Equations

$$\Rightarrow I_E = qA \left[ \left( \frac{D_E n_{E0}}{L_E} + \frac{D_B p_{B0}}{L_B} \frac{\cosh(W/L_B)}{\sinh(W/L_B)} \right) (e^{qV_{EB}/kT} - 1) - \left( \frac{D_B p_{B0}}{L_B} \frac{1}{\sinh(W/L_B)} \right) (e^{qV_{CB}/kT} - 1) \right]$$

$$\alpha_F I_{F0} = \alpha_R I_{R0}$$

$$\Rightarrow I_C = qA \left[ \left( \frac{D_B p_{B0}}{L_B} \frac{1}{\sinh(W/L_B)} \right) (e^{qV_{EB}/kT} - 1) - \left( \frac{D_C n_{C0}}{L_C} + \frac{D_B p_{B0}}{L_B} \frac{\cosh(W/L_B)}{\sinh(W/L_B)} \right) (e^{qV_{CB}/kT} - 1) \right]$$

$I_{F0}, I_{R0}$ : Emitter and Collector Diode Saturation Currents

$I_{R0}$

$\alpha_F$  and  $\alpha_R$ : Forward and Reverse Gains

# Ebers-Moll BJT Model

- Rewriting  $I_E$  and  $I_C$  equations yields:

$$I_E = I_{F0}(e^{qV_{EB}/kT} - 1) - \alpha_R I_{R0}(e^{qV_{CB}/kT} - 1)$$

$$I_C = \alpha_F I_{F0}(e^{qV_{EB}/kT} - 1) - I_{R0}(e^{qV_{CB}/kT} - 1)$$

- Those equations can be represented by the Ebers-Moll BJT model shown below:

